Selective Catalytic Oxidation of Cyclohexene with Molecular Oxygen: Radical Versus Nonradical Pathways
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Figure S1. Scanning electron micrographs of Cu/N:C. The size of the copper oxide is ca. 200-250 nm. Scanning electron microscopy (SEM) of Cu/N:C catalyst with particle measurements. The average size of the copper oxide spherical particles is ca. 200-250 nm. Furthermore, the clusters are evenly distributed onto the support surface.

Figure S2. Temperature programmed reduction (TPR) spectrum for Cu/N:C. The temperature programmed reduction (TPR) shows multiple copper oxide species presence inside the copper oxide catalyst. At 300 °C copper oxide is reduced, where multiple peaks indicate multiple copper oxide species. At 600 °C the support N:C is reduced. [1]
**Figure S3.** X-ray powder diffraction (XRD) spectrum for Cu/N:C.

X-ray diffraction showed a broad peak at 25° which is typical for carbon. The small peaks at 36.1° (-111) and at 39° (111) are typical for CuO.\[2\]

**Figure S4.** Thermal gravimetric analysis (TGA) curves of Cu/N:C and plain N:C.

TGA showed the mass loss of N:C at 500°C, whereas the Cu/N:C has a mass loss at a lower temperature. This difference indicates that the copper oxidises the nitrogen-doped surface during the treatment, thereby lowering the temperature of the mass loss. The difference in weight percentage at the end of the measurement around 600 °C is the copper oxide that is present in the Cu/N:C sample.

**References**
